Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/675,893	REDDY ET AL.
Examiner	Art Unit
Huy D. Nguyen	2681

	SEARCHED					
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4	55	426.2	6/22/2005		ни	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East; Text Search	6/22/2005	HN	
East (USPAT, US-PGPUB, EPO, TPO, DERWENT).	12/06/05	ffpl	
See search history printout. See interference search printout.	12/06/05	#N	